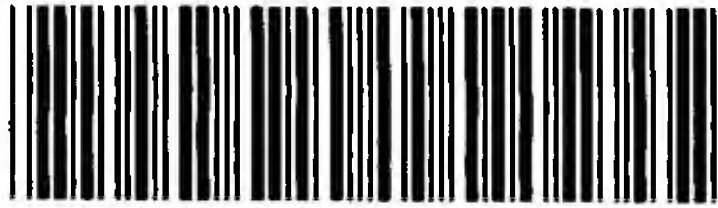


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/059,421	SHIBUYA ET AL.	
	Examiner	Art Unit	
	Cheyne D. Ly	2168	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated search in Google scholar	11/13/2007	CDL